

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Report No: CCISE180804701

FCC REPORT

(GSM & WCDMA)

Applicant: Sun Cupid Technology (HK) Ltd.

Address of Applicant: 16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan,

Kowloon, Hong Kong.

Equipment Under Test (EUT)

Product Name: LTE Smart phone

Model No.: A6L-C, A6LC

Trade mark: NUU

FCC ID: 2ADINA6LC

FCC CFR Title 47 Part 2

Applicable standards: FCC CFR Title 47 Part 22 Subpart H

FCC CFR Title 47 Part 24 Subpart E

FCC CFR Title 47 Part 27 Subpart L

Date of sample receipt: 21 Aug., 2018

Date of Test: 21 Aug., to 13 Sep., 2018

Date of report issued: 14 Sep., 2018

Test Result: PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2. Version

Version No.	Date	Description
00	14 Sep., 2018	Original

Tested by: Quen (hen Date: 14 Sep., 2018

Test Engineer

Reviewed by: Date: 14 Sep., 2018

Project Engineer



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4 Test Summary

Test Item	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Pass (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(2) Part 24.232 (c) Part 27.50 (d)(4)	Pass
Peak-to-Average Power Ratio	Part 24.232 (d) Part 27.50(d)(5)	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53(h)	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Out of band emission, Band Edge	Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Frequency stability vs. temperature	Part 22.355 Part 24.235 Part 27.54 Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 22.355 Part 24.235 Part 27.54 Part 2.1055(d)(2)	Pass

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5. General Information

5.1 Client Information

Applicant:	Sun Cupid Technology (HK) Ltd.
Address:	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.
Manufacturer	Sun Cupid Technology (HK) Ltd.
Address:	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.
Factory:	SUNCUPID (ShenZhen) Electronic Ltd
Address:	Baolong Industrial City, Longgang District, Shenzhen Hi-Tech Road, Building 1, A 7, China.

5.2 General Description of E.U.T.

Product Name:	LTE Smart phone
Model No.:	A6L-C, A6LC
Operation Frequency range:	GSM 850: 824.20MHz-848.80MHz
	PCS1900: 1850.20MHz-1909.80MHz
	WCDMA Band V: 826.4MHz-846.6MHz
	WCDMA Band II: 1852.4 MHz-1907.6 MHz
	WCDMA Band IV: 1712.4 MHz-1752.6 MHz
Modulation type:	GSM/GPRS: GMSK, UMTS: QPSK, EGPRS: 8PSK
Antenna type:	Internal Antenna
Antenna gain:	GSM 850: 0.85 dBi
	PCS 1900: 1.46 dBi
	WCDMA Band II:1.46 dBi
	WCDMA Band IV: 0.70 dBi
	WCDMA Band V: 0.85 dBi
Power supply:	Rechargeable Li-ion Battery DC3.8V-2350mAh
AC adapter:	Model: RD0501000-USBA-18MG
	Input: AC100-240V, 50/60Hz, 0.25A
	Output: DC 5.0V, 1000mA
Remark:	LTE Smart phone item No.: A6L-C, A6LC were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name and for different areas.





Operation Frequency List:

peration Frequency List:				
	<u>/</u> 1 850	PCS1900		
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
128	824.20	512	1850.20	
129	824.40	513	1850.40	
189	836.40	660	1879.80	
190	836.60	661	1880.00	
191	836.80	662	1880.20	
250	848.60	809	1909.60	
251	848.80	810	1909.80	
WCDM	A Band V	WCDN	MA Band II	
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
4132	826.40	9262	1852.40	
4133	826.60	9263	1852.60	
••••				
4182	836.40	9399	1879.80	
4183	836.60	9400	1880.00	
4184	836.80	836.80 9401		
4232	846.40	9537	1907.40	
4233	846.60	9538	1907.60	
WCDMA	A Band IV			
Channel	Frequency (MHz)			
1312	1712.40			
1313	1712.60			
1412	1732.40			
1413	1732.60			
1414	1732.80			
•••				
1512	1752.40			
1513	1752.60			

Regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

GSM850			PCS1900		
Channel		Frequency(MHz)	Channel		Frequency(MHz)
Lowest channel	128	824.20	Lowest channel	512	1850.20
Middle channel	190	836.60	Middle channel	661	1880.00
Highest channel	251	848.80	Highest channel	810	1909.80
1	WCDMA Band \	1	•	WCDMA Band I	
Chann	iel	Frequency(MHz)	Channel		Frequency(MHz)
Lowest channel	4132	826.40	Lowest channel	9262	1852.40
Middle channel	4183	836.60	Middle channel	9400	1880.00
Highest channel	4233	846.60	Highest channel	9538	1907.60
V	VCDMA Band IV	/			
Channel		Frequency(MHz)			
Lowest channel	1312	1712.40			
Middle channel	1413	1732.60			
Highest channel	1513	1752.60			

5.3 Test modes

Operating Environmen	Operating Environment:		
Temperature:	Normal: 15℃ ~ 35℃, Extreme: -30℃ ~ +50℃		
Humidity:	20 % ~ 75 % RH		
Atmospheric Pressure:	1008 mbar		
Voltage:	Nominal: 3.8Vdc, Extreme: Low 3.5 Vdc, High 4.35 Vdc		
Test mode:			
GSM mode	Keep the EUT communication with simulated station in GSM mode		
GPRS mode	Keep the EUT communication with simulated station in GPRS mode		
EGPRS mode	Keep the EUT communication with simulated station in EGPRS mode		
RMC mode	Keep the EUT communication with simulated station in RMC mode		
HSDPA	Keep the EUT communication with simulated station in HSDPA mode		
HSUPA	Keep the EUT communication with simulated station in HSUPA mode		

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Remark: The EUT has been tested under continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing. The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for these modes with power adaptor, earphone and Data cable. Just the worst case position (H mode) shown in report.

5.4 Description of Support Units

Test Equipment	Manufacturer	Model No.	Serial No.	
Simulated Station	Anritsu	MT8820C	6201026545	

5.5 Measurement Uncertainty

Parameters	Expanded Uncertainty
Radiated Emission (9kHz ~ 30MHz)	±2.76 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	±4.28 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	±5.72 dB (k=2)
Radiated Emission (18GHz ~ 40GHz)	±2.88 dB (k=2)

5.6 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 727551

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The Registration No. is 727551.

IC - Registration No.: 10106A-1

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

A2LA - Registration No.: 4346.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: https://portal.a2la.org/scopepdf/4346-01.pdf

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5.7 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

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Email: info@ccis-cb.com, Website: http://www.ccis-cb.com

5.8 Test Instruments list

Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	03-16-2018	03-15-2019
Biconical Antenna	SCHWARZBECK	VUBA9117	359	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-16-2018	03-15-2019
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170582	11-21-2017	11-20-2018
EMI Test Software	AUDIX	E3	V	ersion: 6.110919b)
Pre-amplifier	HP	8447D	2944A09358	03-07-2018	03-06-2019
Pre-amplifier	CD	PAP-1G18	11804	03-07-2018	03-06-2019
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-07-2018	03-06-2019
Spectrum analyzer	Rohde & Schwarz	FSP40	100363	11-21-2017	11-20-2018
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-07-2018	03-06-2019
Spectrum Analyzer	Agilent	N9020A	MY50510123	11-10-2017	11-09-2018
Signal Generator	Rohde & Schwarz	SMX	835454/016	03-07-2018	03-06-2019
Signal Generator	R&S	SMR20	1008100050	03-07-2018	03-06-2019
RF Switch Unit	MWRFTEST	MW200	N/A	N/A	N/A
Test Software	MWRFTEST	MTS8200	Version: 2.0.0.0		
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-07-2018	03-06-2019
Cable	MICRO-COAX	MFR64639	K10742-5	03-07-2018	03-06-2019
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-07-2018	03-06-2019
DC Power Supply	XinNuoEr	WYK-10020K	1409050110020	10-31-2017	10-30-2018
Temperature Humidity Chamber	HengPu	HPGDS-500	20140828008	09-24-2017	09-23-2018
Simulated Station	Rohde & Schwarz	CMW500	140493	06-24-2018	06-23-2019



6. Test results

6.1 Conducted Output Power, ERP and EIRP

Test Requirement:	FCC part 22.913(a)(2), FCC part 24.232(c), FCC part 27.50(d)(4)		
Test Method:	ANSI/TIA-603-D 2010		
Limit:	GSM 850: 7W, PCS 1900: 2W WCDMA Band V: 7W, WCDMA Band II: 2W, WCDMA Band IV: 1W		
Test setup:	System simulator ATT EUT		
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the simulated station. Transmitter output power was read off in dBm.		
Test Instruments:	Refer to section 5.8 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed		





Measurement Data:

	Burst	Average power	(dBm)	Antonno	May EDD	EDD Lineit
EUT Mode	128	190	251	Antenna Max. ERP	ERP Limit	
	824.20MHz	836.60MHz	848.80MHz	Gain (dBi)	(dBm)	(dBm)
GSM 850	32.67	32.72	32.65	0.85	31.42	
GPRS 850 (1 Uplink slot)	32.48	32.55	32.50			
GPRS 850 (2 Uplink slot)	31.72	31.76	31.71	0.05	24.25	
GPRS 850 (3 Uplink slot)	29.84	29.93	29.91	0.85	31.25	
GPRS 850 (4 Uplink slot)	28.68	28.80	28.82			38.45
EGPRS 850 (1 Uplink slot)	26.87	26.89	26.86			
EGPRS 850 (2 Uplink slot)	25.75	25.84	25.76	0.85	25.59	
EGPRS 850 (3 Uplink slot)	23.66	23.74	23.72			
EGPRS 850 (4 Uplink slot)	22.32	22.44	22.37			
	Burst Average power (dBm)			Antono	Maria EIDD	EIRP Limit
EUT Mode	512	661	810	Antenna	Max. EIRP	
	1850.20MHz	1880.00MHz	1909.80MHz	Gain (dBi)	(dBm)	(dBm)
PCS 1900	29.72	29.80	29.88	1.46	31.34	
GPRS 1900 (1 Uplink slot)	29.61	29.67	29.77			
GPRS 1900 (2 Uplink slot)	28.68	28.80	28.87	1.46	04.00	
GPRS 1900 (3 Uplink slot)	26.95	27.05	27.16	1.40	31.23	
CDDC 4000 (4 Unlink alat)	05.05	25.98	26.10			33.00
GPRS 1900 (4 Uplink slot)	25.87	23.96	20.10			
EGPRS 1900 (4 Uplink slot)	25.87 25.26	25.31	25.25			
				1 46	26.77	
EGPRS 1900 (1 Uplink slot)	25.26	25.31	25.25	1.46	26.77	
EGPRS 1900 (1 Uplink slot) EGPRS 1900 (2 Uplink slot)	25.26 24.17	25.31 24.05	25.25 24.19	1.46	26.77	

Note: EIRP (dBm) = Burst Average power (dBm) + Antenna Gain (dBi).

ERP(dBm) = EIRP(dBm) - 2.15(dB).





EUT Mode 4132 4183 4233 826.40MHz 836.60MHz 846.60MHz UMTS 850 HSDPA Subtest 1 Subtest 2 Subtest 3 Subtest 4 20.25 Subtest 4 20.25 Subtest 1 21.79 Subtest 2 Subtest 2 Subtest 3 Subtest 4 Subtest 4 Subtest 4 Subtest 6 Subtest 6 Subtest 7 Subtest 8 Subtest 8 Subtest 9 Subte	ERP Limit (dBm)
UMTS 850 HSUPA Subtest 1 22.26 22.26 22.24	(dBm)
UMTS 850 HSDPA Subtest 2 21.93 21.90 21.89 Subtest 3 20.37 20.32 20.25 Subtest 4 20.25 20.35 20.33 Subtest 1 21.79 21.69 21.79 Subtest 2 22.18 22.19 22.18 Subtest 3 19.80 19.74 19.83 0.85 Subtest 4 22.23 22.22 22.22	_
HSDPA Subtest 3 20.37 20.32 20.25 0.85 20.96 Subtest 4 20.25 20.35 20.33 20.33 20.35 20.33 20.35 20.33 20.35 20.33 20.35 20.33 20.35 20.3	_
HSDPA Subtest 3 20.37 20.32 20.25 Subtest 4 20.25 20.35 20.33 Subtest 1 21.79 21.69 21.79 Subtest 2 22.18 22.19 22.18 Subtest 3 19.80 19.74 19.83 0.85 Subtest 4 22.23 22.22 22.22 20.93	_
UMTS 850 HSUPA Subtest 1 21.79 21.69 21.79 Subtest 2 22.18 22.19 22.18 Subtest 3 19.80 19.74 19.83 Subtest 4 22.23 22.22 22.22 Subtest 4 22.23 22.22 22.22	_
UMTS 850 HSUPA Subtest 2 22.18 22.19 22.18 Subtest 3 19.80 19.74 19.83 Subtest 4 22.23 22.22 22.22	
HSUPA Subtest 3 19.80 19.74 19.83 0.85 20.93 Subtest 4 22.23 22.22	1
HSUPA Subtest 3 19.80 19.74 19.83 0.85 20.93 Subtest 4 22.23 22.22	38.45
Subtest 4 22.23 22.22 22.22	
Subtest 5 22.38 22.37 22.18	
UMTS 850 RMC 12.2kbps 23.29 23.30 23.26 0.85 22.00	
UMTS 850 AMR 12.2kbps 23.12 23.06 23.02 0.85 21.82	
Burst Average power (dBm)	FIDD Limit
EUT Mode 9262 9400 9538 Antenna Max. EIRP	
1852.40MHz	(dBm)
Subtest 1 22.01 21.91 21.88	
UMTS 1900 Subtest 2 21.65 21.46 21.57 1.46 23.47	
HSDPA Subtest 3 20.12 20.11 19.97	
Subtest 4 20.15 20.09 19.89	
Subtest 1 21.53 21.45 21.33	
Subtest 2 21.95 21.82 21.82	33.00
UMTS 1900 HSUPA Subtest 3 19.60 19.50 19.43 1.46 23.46	3.46
Subtest 4 21.62 21.46 21.49	
Subtest 5 22.00 21.86 21.85	
UMTS 1900 RMC 12.2kbps 23.07 22.97 22.96 1.46 24.53	
UMTS 1900 AMR 12.2kbps 22.98 22.69 22.80 1.46 24.44	
Burst Average power (dBm) Antenna Max. EIRP	EIRP Limit
EUT Mode 1312 1412 1513 Gain (dRii) (dRm)	(dBm)
1712.40MHz 1732.40MHz 1752.60MHz Gain (dBh)	(ubiii)
Subtest 1 22.53 22.56 22.57	
UMTS 1700 Subtest 2 22.15 22.25 22.21 0.70 23.27	
HSDPA Subtest 3 20.52 20.51 20.68	
Subtest 4 20.58 20.69 20.75	
Subtest 1 22.13 22.09 22.12	
UMTS 1700 Subtest 2 22.48 22.51 22.53	33.00
HSUPA Subtest 3 20.09 20.15 20.20 0.70 23.27	
Subtest 4 22.30 22.25 22.18	
Subtest 5 22.53 22.57 22.57	
UMTS 1700 RMC 12.2kbps 23.49 23.64 23.64 0.70 24.34	
UMTS 1700 AMR 12.2kbps 23.43 23.49 23.46 0.70 24.19	

Note: EIRP(dBm) = Burst Average power(dBm) + Antenna Gain(dBi).



6.2 Occupy Bandwidth

Test Requirement:	FCC part 22.917(b), FCC part 24.238(b), FCC Part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Test setup:	System simulator Splitter ATT EUT Spectrum Analyzer
Test Procedure:	 The EUT's output RF connector was connected with a short cable to the spectrum analyzer RBW was set to about 1% of emission BW, VBW= 3 times RBW. -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





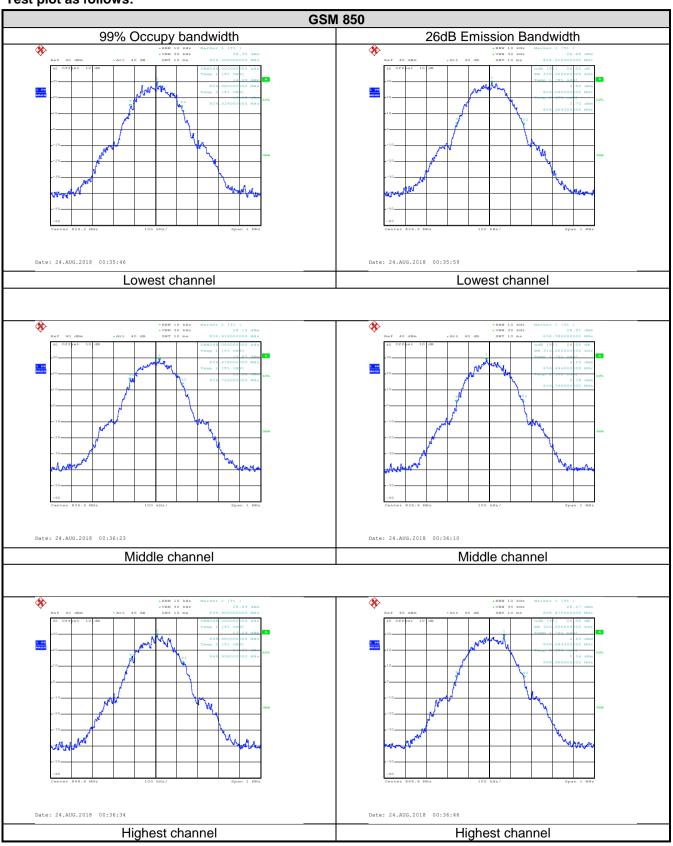
Measurement Data:

moacaromont Batar				
EUT Mode	Channel	Frequency (MHz)	99% Occupy bandwidth (kHz)	-26dB bandwidth (kHz)
	128	824.2	244	318
GSM 850	190	836.6	248	316
	251	848.8	248	322
	128	824.2	244	318
EGPRS850	190	836.6	248	316
	251	848.8	246	306
	512	1850.2	250	302
PCS 1900	661	1880.0	250	318
	810	1909.8	244	314
	512	1850.2	244	310
EGPRS1900	661	1880.0	246	310
	810	1909.8	250	306
LIMTO 050	4132	826.4	4180	4720
UMTS 850 12.2k RMC	4183	836.6	4200	4720
12.2K KIVIC	4233	846.6	4180	4740
LINATO 4000	9262	1852.4	4180	4720
UMTS 1900 12.2k RMC	9400	1880.0	4200	4720
IZ.ZK NIVIC	9538	1907.6	4180	4700
LINATIO 4700	1312	1712.40	4200	4760
UMTS 1700 12.2k RMC	1413	1732.60	4200	4720
IZ.ZK NIVIO	1513	1752.60	4180	4720

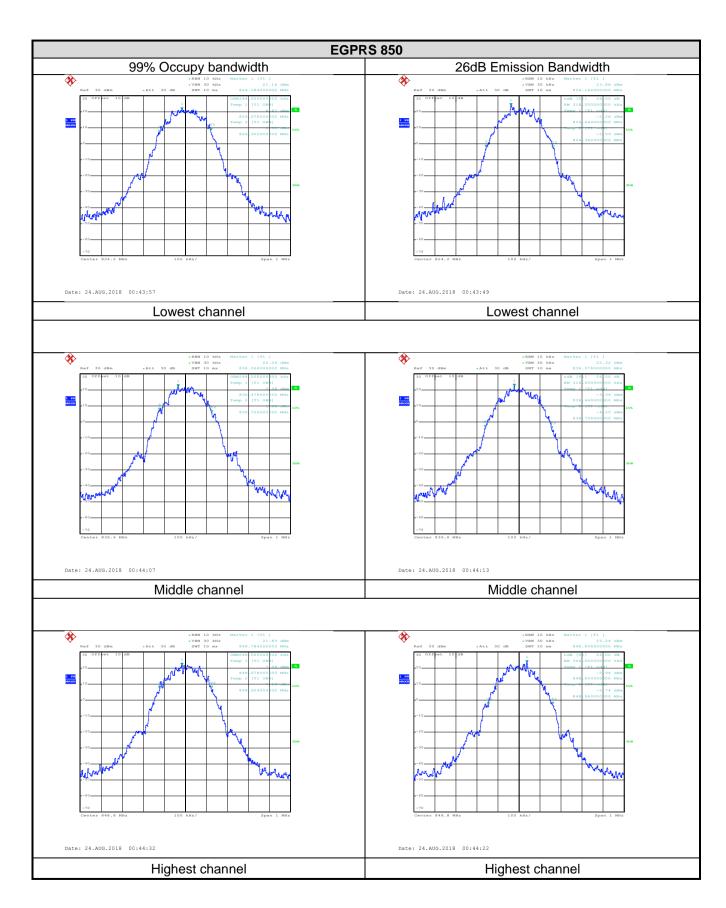
Note: GSM & GPRS use the same modulation technical (GMSK), and with the same channels, so the 99% OBW and the -26dB of GPRS not performed.



Test plot as follows:

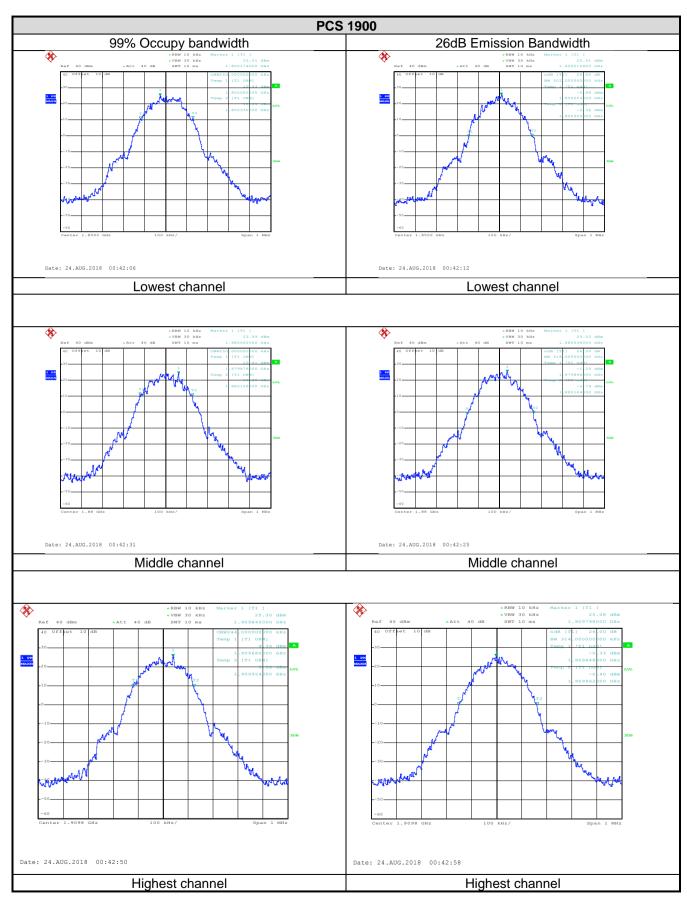






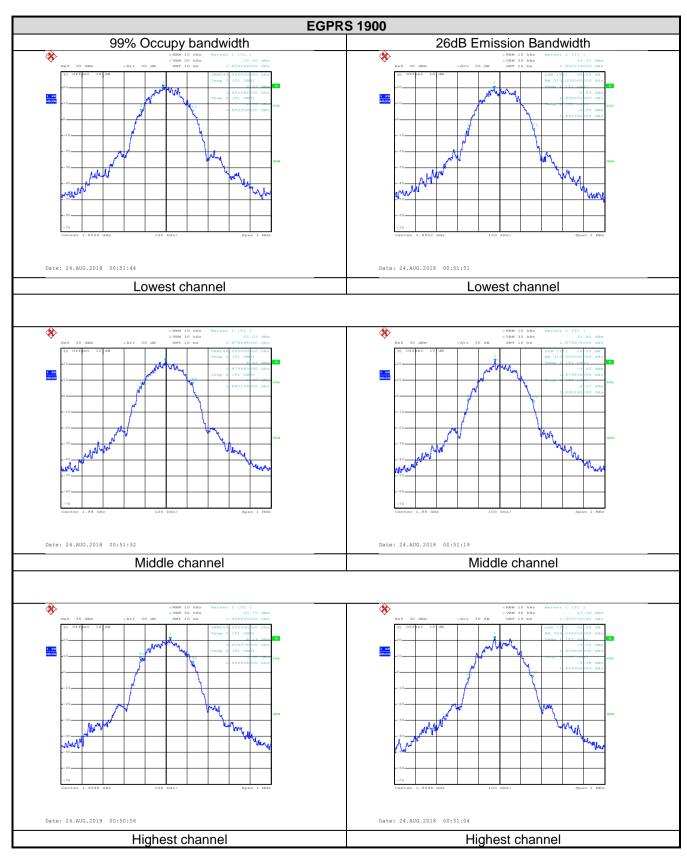




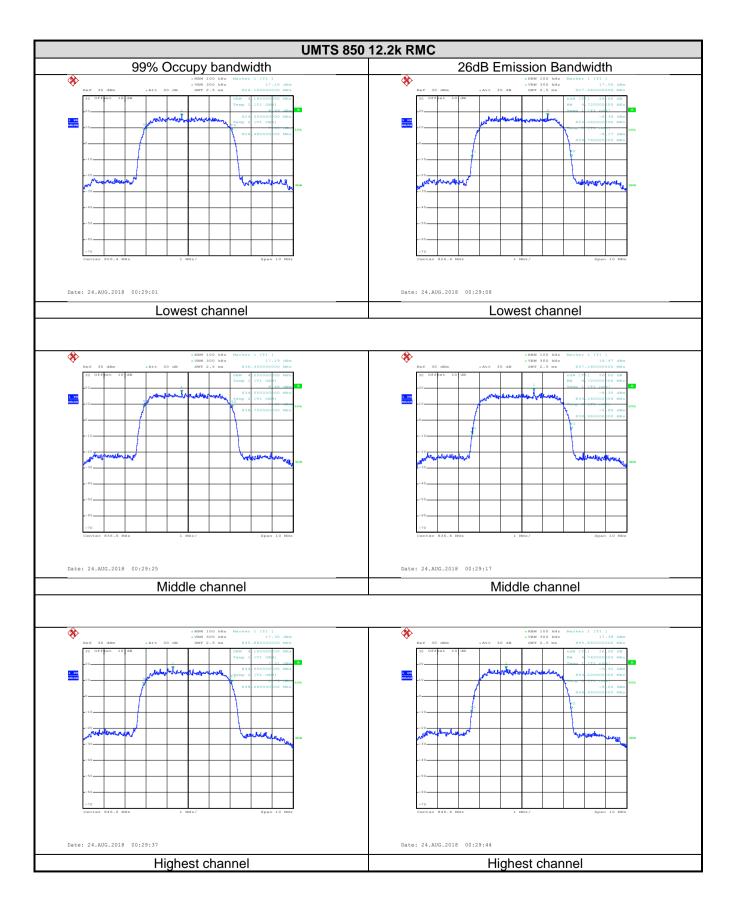




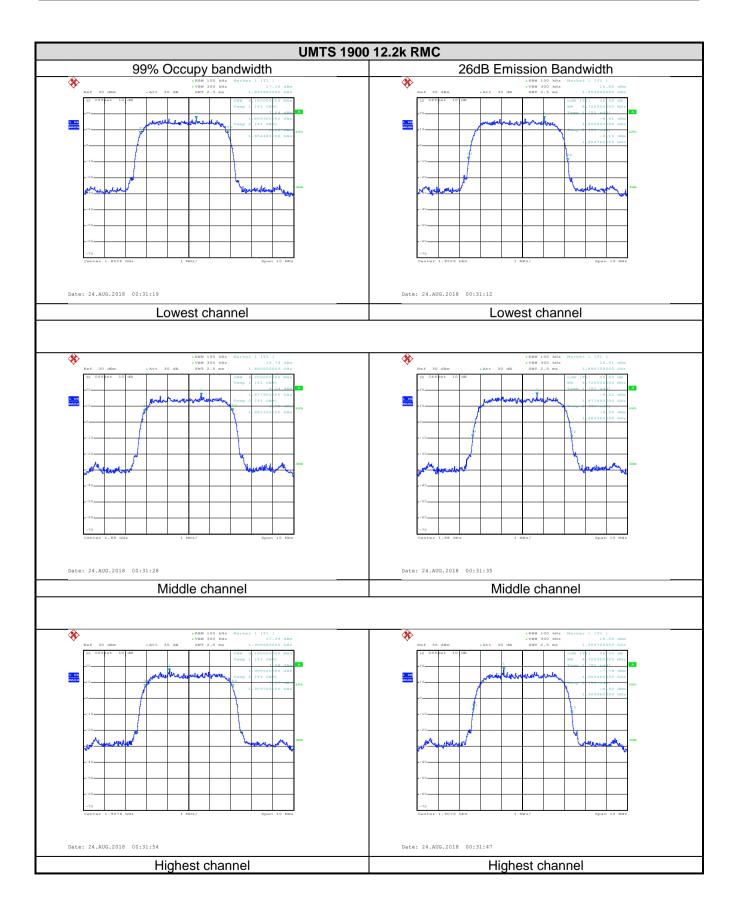




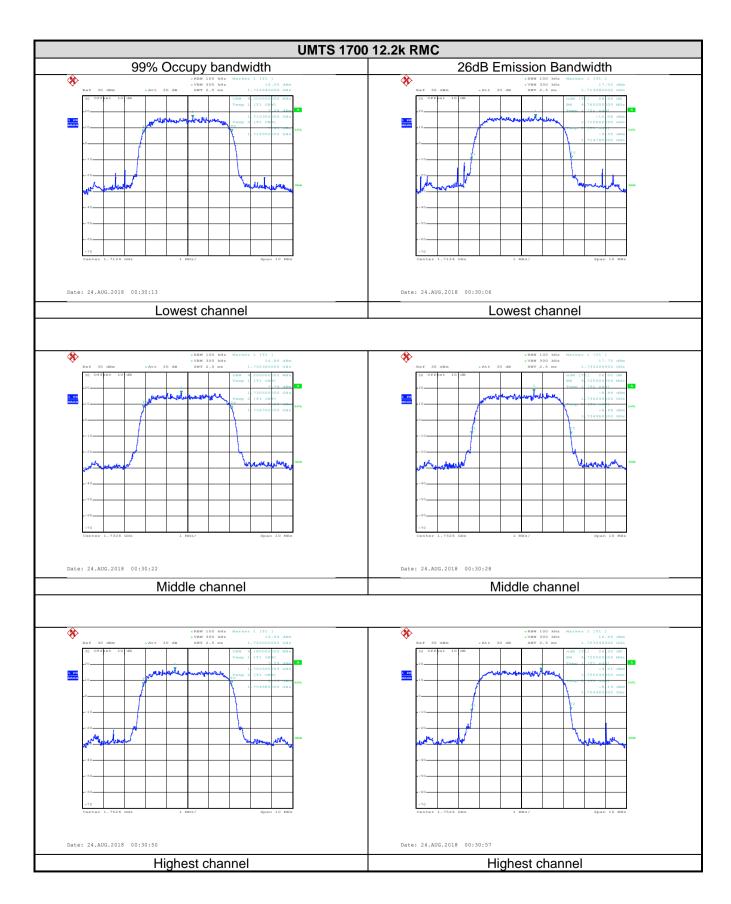














6.3 Peak-to-Average Power Ratio

Test Requirement:	FCC part 24.232(d), FCC part 27.50(d)(5)
Test Method	ANSI/TIA-603-D 2010
Limit:	The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.
Test setup:	System simulator Splitter ATT EUT Spectrum Analyzer
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. Set the CCDF option in spectrum analyzer, RBW ≥ OBW, Set the EUT working in highest power level, measured and recorded the 0.1% as PAPR level. Repeat step 1~3 at other frequency and modulations.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

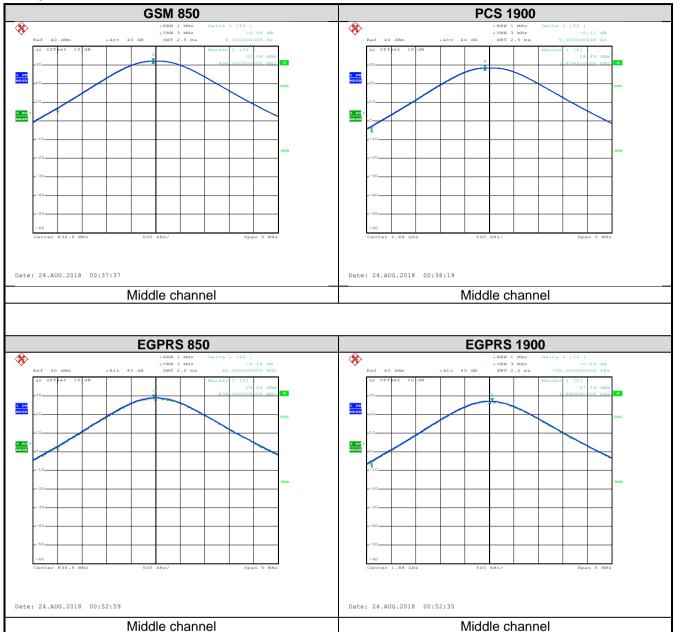
Measurement Data:

Modulation	Test channel	PAPR
GSM 850	190	0.08
EGPRS 850	190	0.11
PCS 1900	661	0.14
EGPRS 1900	661	0.24
UMTS 850 RMC	4183	2.60
UMTS 1900 RMC	9400	2.96
UMTS1700 RMC	1413	2.88

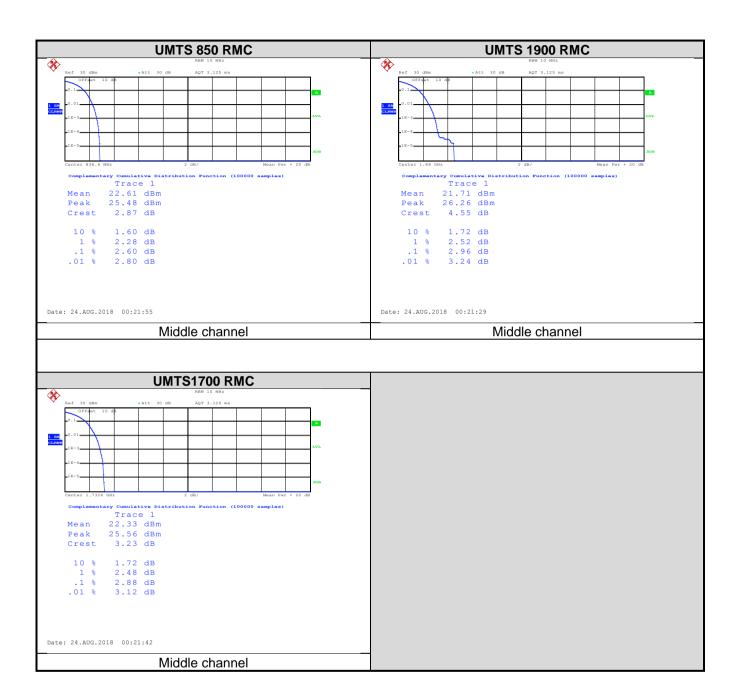




Test plots as below:









6.4 Modulation Characteristic

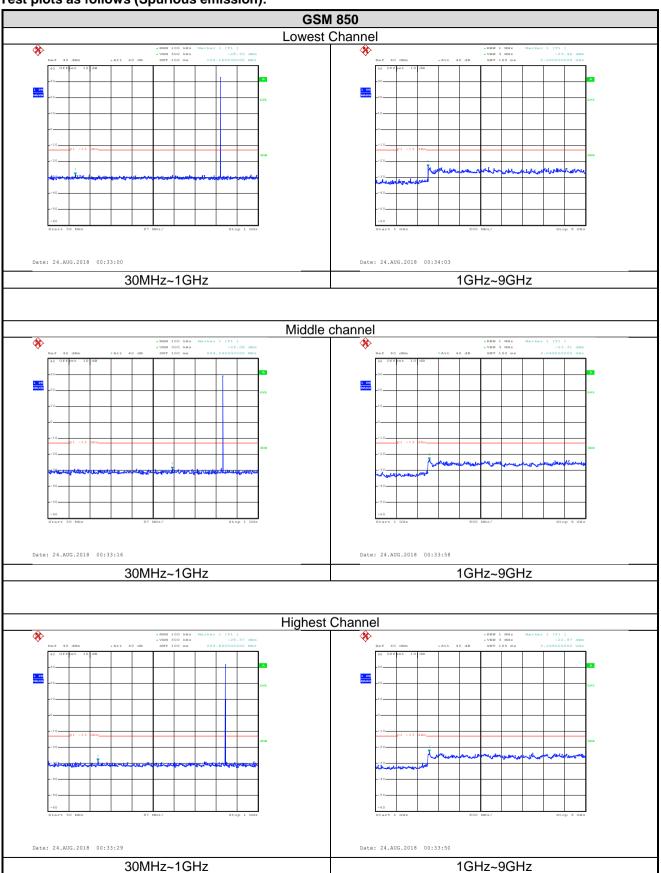
According to FCC § 2.1047(d), Part 22H & 24E & 27L there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

6.5 Out of band emission at antenna terminals

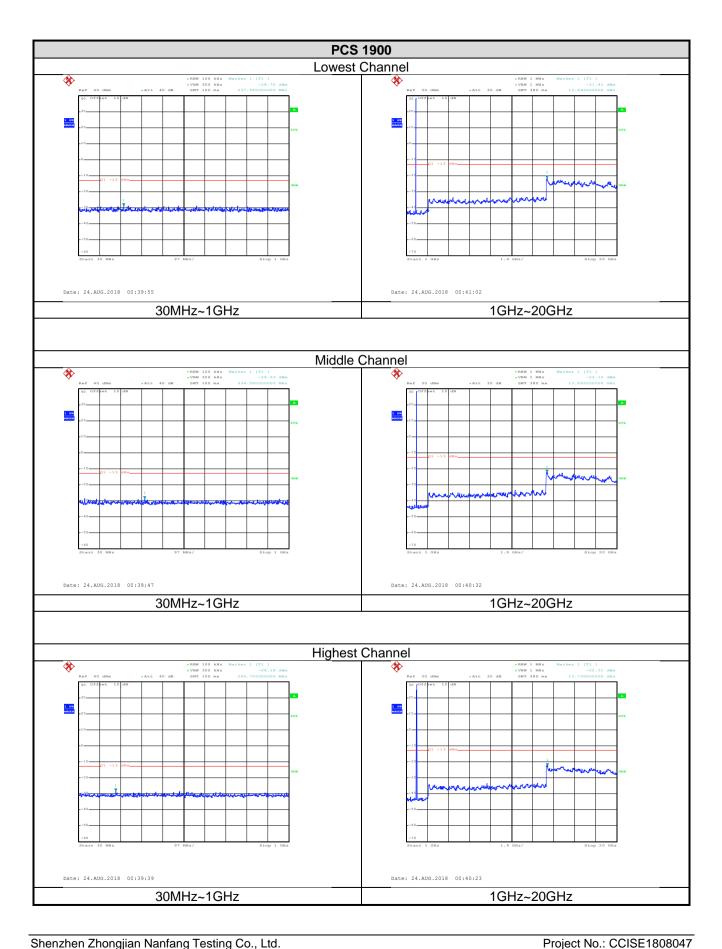
Test Requirement:	FCC part 22.917(a), FCC part 24.238(a), FCC Part 27.53 (h)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Test setup:	System simulator Splitter ATT EUT Spectrum Analyzer
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. The resolution bandwidth of the spectrum analyzer was set at 100 kHz when below 1GHz, 1MHz when above 1 GHz; sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic. For the out of band: Set the RBW=100 kHz, VBW=300 kHz when below 1 GHz, RBW =1 MHz, VBW=3 MHz when above 1 GHz, Start=30MHz, Stop= 10th harmonic. Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed



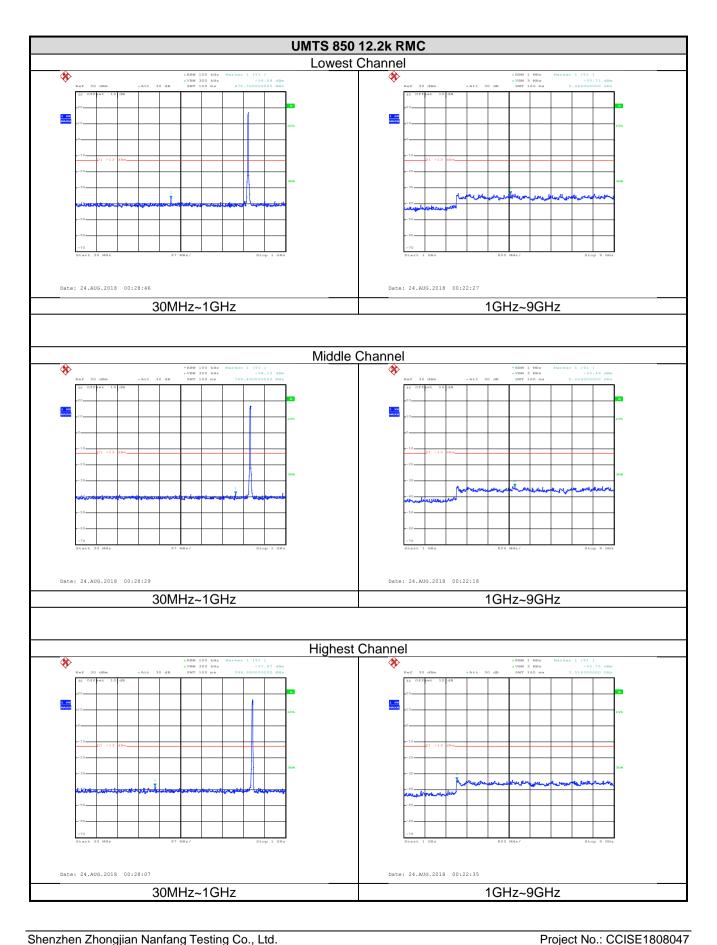
Test plots as follows (Spurious emission):



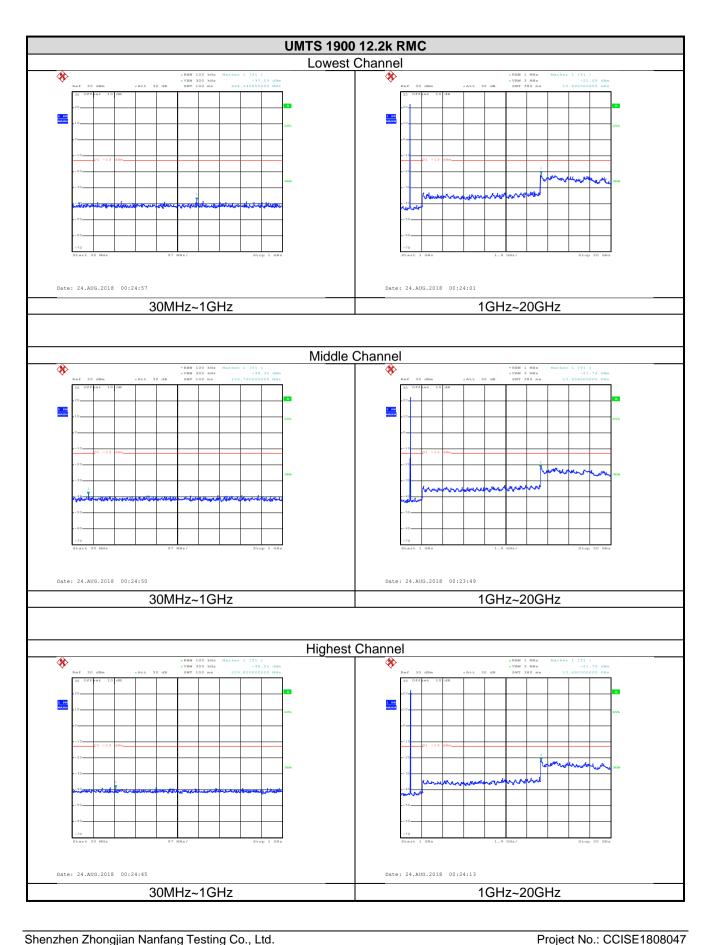




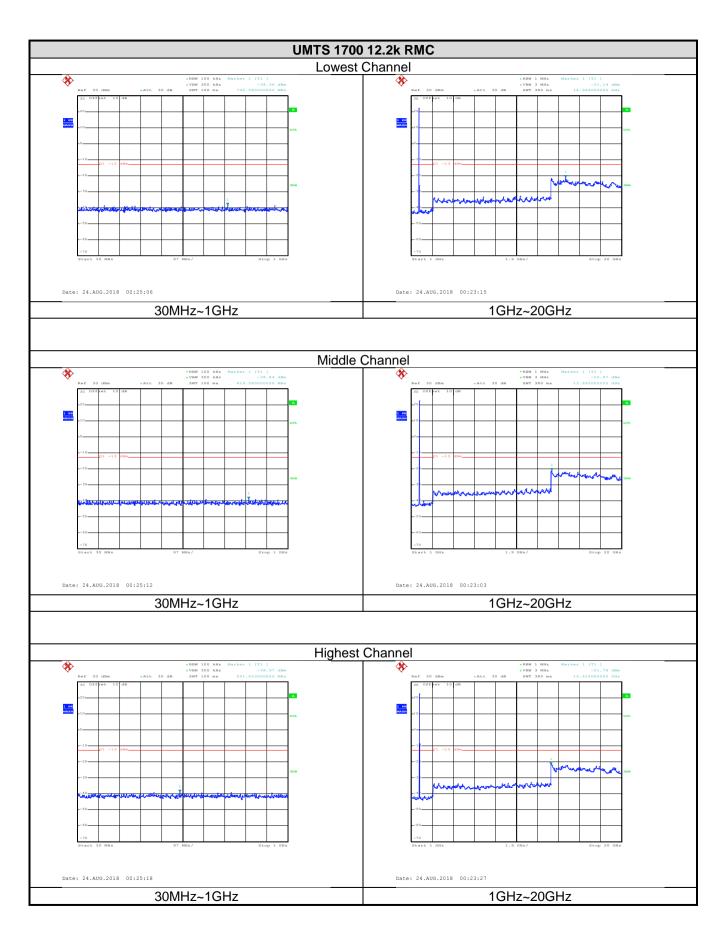








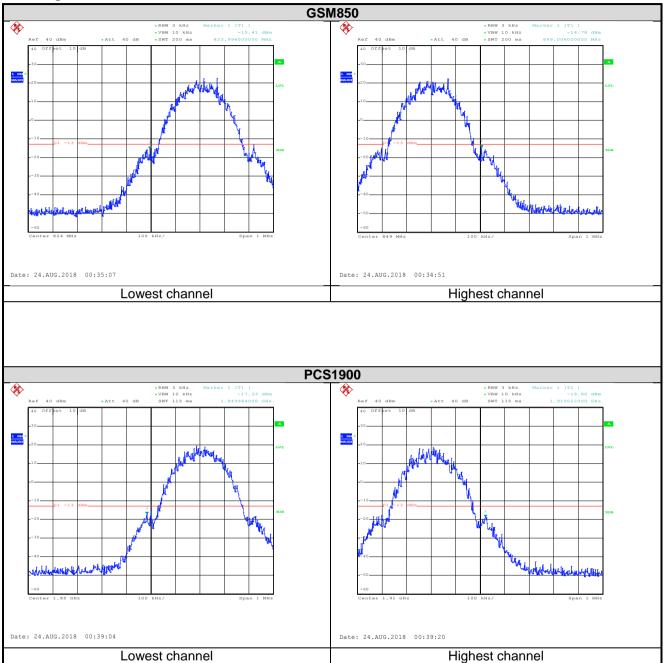




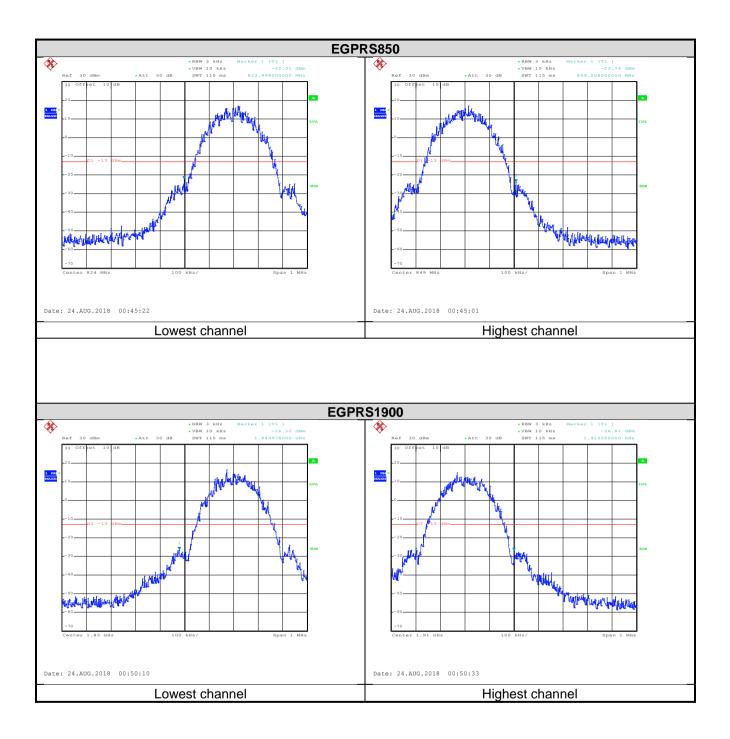




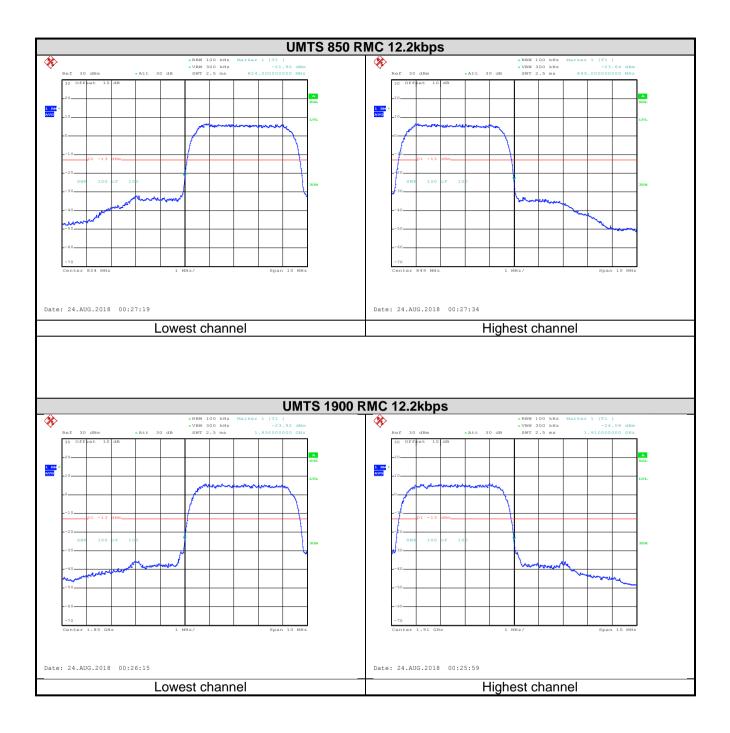
Band edge emission:



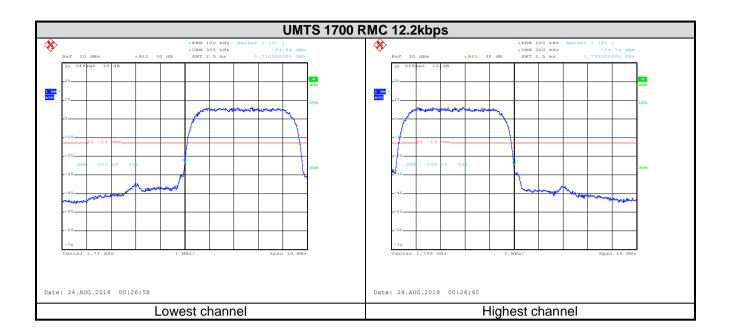














6.6 Field strength of spurious radiation measurement

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a), FCC part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Test setup:	Below 1GHz
	Antenna Tower Test Receiver Test Receiver Antenna Tower Antenna Tower Antenna Tower Antenna Tower Antenna Tower Antenna Tower
	Ground Reference Plane Test Receiver
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non- conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI
	spectrum analyzer.
	2. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the
	EUT. This maximization process was repeated with the EUT
Toot Instruments:	 positioned in each of its three orthogonal orientations. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed





Measurement Data (worst case):

		GSM850		
		Lowest channel		
Fraguency (MHz)	Spurious	Emission	Lineit (-IDne)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
1648.40	Vertical	-50.83		Pass
2472.60	V	-51.01	12.00	
3296.80	V	-49.98	-13.00	
4121.00	V	-49.32		
1648.40	Horizontal	-48.99		
2472.60	Н	-47.53	40.00	Dana
3296.80	Н	-50.67	-13.00	Pass
4121.00	Н	-48.86	-	
		Middle channel		
F (NALL)	Spurious Emission		Livit (IDv)	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1673.20	Vertical	-46.92	-13.00	Pass
2509.80	V	-51.05		
3346.40	V	-50.93		
4183.00	V	-49.28		
1673.20	Horizontal	-47.06		_
2509.80	Н	-45.75	40.00	
3346.40	Н	-51.28	-13.00	Pass
4183.00	Н	-46.62	-	
		Highest channel		
F (NALL)	Spurious	Emission	L':'(/ ID)	D !!
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1697.60	Vertical	-47.15		
2546.40	V	-50.16	40.00	Dana
3395.20	V	-50.71	-13.00	Pass
4244.00	V	-48.65	-	
1697.60	Horizontal	-47.02		
2546.40	Н	-42.58	10.00	D -
3395.20	Н	-51.80	-13.00	Pass
4244.00	Н	-48.31		

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.





		PCS1900		
		Lowest channel		
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (Miriz)	Polarization	Level (dBm)	Lilliit (dbill)	Result
3700.40	Vertical	-49.36	-13.00	Pass
5550.60	V	-40.84	-13.00	F455
3700.40	Horizontal	-46.30	-13.00	Door
5550.60	Н	-32.77	-13.00	Pass
		Middle channel		
Fraguency (MILIT)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3760.00	Vertical	-49.19	-13.00	Door
5640.00	V	-44.06	-13.00	Pass
3760.00	Horizontal	-48.47	42.00	Door
5640.00	Н	-40.17	-13.00	Pass
		Highest channel		
Fragues ov (MHz)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3819.60	Vertical	-47.92	12.00	Door
5729.40	V	-37.67	-13.00	Pass
3819.60	Horizontal	-45.28	12.00	Door
5729.40	Н	-42.53	-13.00	Pass
Remark:				

The emission levels of below 1 GHz are very lower than the limit and not show in test report.





	WCD	MA BAND V 12.2k RN	IC	
		Lowest channel		
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (Miriz)	Polarization	Level (dBm)	LIIIII (UDIII)	- Resuit
1652.80	Vertical	-58.09		
2479.20	V	-45.30	-13.00	Pass
3305.60	V	-51.49	-13.00	Pass
4132.00	V	-49.07		
1652.80	Horizontal	-58.81		
2479.20	Н	-43.51	10.00	Dana
3305.60	Н	-51.74	-13.00	Pass
4132.00	Н	-49.54		
		Middle channel		
Fraguency (MUT)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
1673.20	Vertical	-58.23	-13.00	Pass
2509.80	V	-55.60		
3346.40	V	-51.76		
4183.00	V	-48.73		
1673.20	Horizontal	-58.62		
2509.80	Н	-55.22	42.00	
3346.40	Н	-51.68	13.00	Pass
4183.00	Н	-49.76	-	
		Highest channel		
Francisco (MIII-)	Spurious	Emission	Lineit (dDne)	Decult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1693.20	Vertical	-57.59		
2539.80	V	-54.02	40.00	D
3386.40	V	-51.52	-13.00	Pass
4233.00	V	-47.06]	
1693.20	Horizontal	-58.50		
2539.80	Н	-53.80	1 40.00	Б.
3386.40	Н	-50.05	-13.00	Pass
4233.00	Н	-48.52	1	

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.





WCDMA Band II 12.2k RMC				
		Lowest channel		
Fraguanay (MHz)	Spurious	Emission	Limit (dPm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3704.80	Vertical	-49.67	-13.00	Pass
5557.20	V	-44.54	-13.00	Pass
3704.80	Horizontal	-47.64	12.00	Door
5557.20	Н	-43.59	-13.00	Pass
		Middle channel		
Fragues ov (MHz)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
3760.00	Vertical	-48.88	12.00	Door
5640.00	V	-43.99	-13.00	Pass
3760.00	Horizontal	-46.13	12.00	Door
5640.00	Н	-44.39	-13.00	Pass
		Highest channel		
Fraguera, (MIII-)	Spurious	Spurious Emission		Danult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3815.20	Vertical	-48.63	42.00	Door
5722.80	V	-44.50	-13.00	Pass
3815.20	Horizontal	-46.02	42.00	Door
5722.80	Н	-43.67	-13.00	Pass
Remark:				

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.





WCDMA Band IV 12.2k RMC							
		Lowest channel					
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result			
Frequency (MHZ)	Polarization	Level (dBm)	LIIIII (UDIII)	Resuit			
3424.40	Vertical	-50.07	12.00	Door			
5136.60	V	-47.12	-13.00	Pass			
3424.40	Horizontal	-49.63	42.00	Dese			
5136.60	Н	-46.12	-13.00	Pass			
Middle channel							
Fraguenov (MILIT)	Spurious Emission		Limit (dDm)	Dooult			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
3464.80	Vertical	-48.47	-13.00	Dese			
5197.20	V	-46.16	-13.00	Pass			
3464.80	Horizontal	-49.41	42.00	Dese			
5197.20	Н	-46.13	-13.00	Pass			
		Highest channel					
Fragues av (MILIE)	Spurious	Emission	L' '(/ ID)	D !!			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
3505.20	Vertical	-49.95	42.00	Dese			
5257.80	V	-46.14	-13.00	Pass			
3505.20	Horizontal	-49.61	42.00	Dese			
5257.80	Н	-45.72	-13.00	Pass			
Remark:							

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.



6.7 Frequency stability V.S. Temperature measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 27.54, FCC Part 2.1055(a)(1)(b)
Test Method:	ANSI/TIA-6-3-D 2010
Limit:	±2.5 ppm
Test setup:	SS EUT Divider SA Temperature & Humidity Chamber
Test procedure:	 The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (the worst channel):

Refe	rence Frequency: GS	M850 Middle	channel=190 char	nnel=836.6MHz	
Power supplied	Temperature (°C)	Frequency error		Limit (mmm)	Decult
(Vdc)	remperature (C)	Hz	ppm	Limit (ppm)	Result
	-30	173	0.206789		Pass
	-20	154	0.184078	1	
	-10	135	0.161367		
	0	124	0.148219		
3.80	10	113	0.135071	±2.5	
	20	141	0.168539		
	30	138	0.164953	_	
	40	127	0.151805		
	50	116	0.138656		
Refe	rence Frequency: PC	S1900 Middle	e channel=661 cha	nnel=1880MHz	
Power supplied	Temperature (°C)	Freq	uency error	Limit (ppm)	Result
(Vdc)	Temperature (C)	Hz	ppm		
	-30	181	0.096277		
	-20	158	0.084043		Pass
	-10	144	0.076596		
3.80	0	132	0.070213		
	10	128	0.068085	±2.5	
	20	119	0.063298		
	30	110	0.058511		
	40	141	0.075000		
	50	149	0.079255		

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Power supplied	_	Frequency error			
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	176	0.210375		Pass
	-20	157	0.187664		
	-10	138	0.164953	1	
	0	127	0.151805		
3.80	10	116	0.138656	±2.5	
	20	144	0.172125		
	30	141	0.168539		
	40	130	0.155391		
	50	119	0.142242		
Refere	ence Frequency: EGP	RS 1900 Mid	dle channel=661 ch	nannel=1880MHz	
Power supplied	Temperature (°C)	Freq	uency error	Limit (ppm)	Result
(Vdc)	remperature (c)	Hz	ppm		
	-30	178	0.094681		Pass
	-20	155	0.082447		
	-10	141	0.075000		
	0	129	0.068617		
3.80	10	125	0.066489	±2.5	
	20	116	0.061702		
	30	107	0.056915		
	40	138	0.073404		
	50	146	0.077660		





Reference Fred	quency: WCDMA BAN			=4183 channel=8	36.6MHz
Power supplied	Temperature (°C)		uency error	Limit (ppm)	Result
(Vdc)	Tomporataro (c)	Hz	ppm	Limit (ppm)	Kesuit
	-30	171	0.204399		
	-20	144	0.172125		
	-10	137	0.163758		
	0	124	0.148219		Pass
3.80	10	110	0.131485	±2.5	
	20	162	0.193641		
	30	164	0.196032		
	40	140	0.167344		
	50	147	0.175711		
Reference Fre	quency: WCDMA BAN	ID II 12.2k RN	MC Middle channe	l=9400 channel=1	880MHz
Power supplied	Temperature (°C)	Frequency error		Limit (ppm)	Result
(Vdc)	remperature (C)	Hz	ppm	Limit (ppm)	Result
	-30	192	0.102128		
	-20	154	0.081915		Pass
	-10	145	0.077128		
	0	168	0.089362	±2.5	
3.80	10	147	0.078191		
	20	129	0.068617		
	30	150	0.079787		
	40	138	0.073404		
	50	154	0.081915		
Reference F	requency: UMTS1700	12.2k RMC N	/liddle channel=14	13 channel=1732.	6MHz
Power supplied	Temperature (°C)	Frequency error		Limit (nnm)	D!
(Vdc)	Temperature (C)	Hz	ppm	Limit (ppm)	Result
	-30	174	0.100427		
	-20	144	0.083112		
	-10	145	0.083689		
	0	128	0.073877]	1
3.80	10	110	0.063488	±2.5	Pass
	20	146	0.084266	7	
	30	170	0.098118	1	
	40	160	0.092347	7	
			1		



6.8 Frequency stability V.S. Voltage measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 27.54, FCC Part 2.1055(d)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	SS EUT Divider Temperature & Humidity Chamber Power Source
Test procedure:	 Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (the worst channel):

Refer	ence Frequency: G	SM850 Middle	channel=190 chan	nel=836.6MHz			
T(°C)	Power supplied (Vdc)	Frequency error					
Temperature (℃)		Hz	ppm	Limit (ppm)	Result		
	4.35	84	0.100406				
25	3.80	77	0.092039	±2.5	Pass		
	3.55	67	0.080086				
Refer	ence Frequency: PC	CS1900 Middle	channel=661 cha	nnel=1880MHz			
Temperature (℃)	Power supplied	Frequency error		Limit (ppm)	Result		
remperature (c)	(Vdc)	Hz	ppm	Еппі (рріп)	Nesuit		
	4.35	88	0.04681				
25	3.80	72	0.03830	±2.5	Pass		
	3.55	78	0.04149				
Reference Frequency: EGPRS 850 Middle channel= 190 channel=836.6MHz							
Temperature (℃)	Power supplied	Frequency error		Limit (ppm)	Result		
remperatore (c)	(Vdc)	Hz	ppm	Еппт (ррпп)	resuit		
	4.35	98	0.117141				
25	3.80	90	0.107578	±2.5	Pass		
	3.55	72	0.086063				
Referen	ce Frequency: EGP	RS 1900 Midd	le channel= 661 ch	nannel=1880MHz			
Temperature (°C)	Power supplied	Frequency error		Limit (ppm)	Result		
remperature (C)	(Vdc)	Hz	ppm	Еппі (рріп)	Result		
25	4.35	87	0.046277				
	3.80	76	0.040426	±2.5	Pass		
	3.55	88	0.046809				
Note: Only the worst case	e shown in the report.						





Reference	Frequency: UMTS 8	50 12.2k RMC Mi	ddle channel=41	83 channel=836.6	6MHz
Temperature (°C)	Power supplied	Frequer	ncy error		Result
	(Vdc)	Hz	ppm	Limit (ppm)	
	4.35	86	0.102797		
25	3.80	92	0.109969	±2.5	Pass
	3.55	65	0.077695		
Reference I	requency: UMTS 19	900 12.2k RMC N	liddle channel=9	400 channel=1880	OMHz
Tomporature (°C)	Power supplied	Frequency error		Limit (mmm)	Danill
Temperature (°C)	(Vdc)	Hz	ppm	Limit (ppm)	Result
	4.35	80	0.042553		
25	3.80	83	0.044149	±2.5	Pass
	3.55	71	0.037766		
Reference F	requency: UMTS170	00 12.2k RMC Mi	ddle channel=14	13 channel=1732.	6MHz
Tomporature (°C)	Power supplied	Frequency error		Limit (nnm)	Result
Temperature (°C)	(Vdc)	Hz	ppm	Limit (ppm)	Result
	4.35	92	0.053099		
25	3.80	86	0.049636	2.5	Pass
	3.55	59	0.034053		
Note: Only the worst cas		59	0.034053		